

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/616,097 <i>ANJ 2105</i>	SUN ET AL.	
Examiner Edna Wong		Art Unit 1753		Page 1 of 1

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*	B	US-6,432,821	08-2002	Dubin et al.	438/678
	C	US-6,709,563	03-2004	Nagai et al.	205/123
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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